

Notice of References Cited	Application/Control No. 10/738,397	Applicant(s)/Patent Under Reexamination JIN ET AL.	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0155595	08-2003	Okita, Yoichi	257/295
*	C	US-2002/0192868	12-2002	Kim, Do-Hyung	438/112
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NON-PATENT DOCUMENTS

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